Notice of References Cited

Application/Control No. 10/550,082	Reexamination	Applicant(s)/Patent Under Reexamination OGAWA ET AL.		
Examiner	Art Unit			
Dmitry Suhol	3725	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,619,087	09-2003	Ogawa et al.	72/14.4
*	В	US-6,354,128	03-2002	Donini et al.	72/237
*	C	US-6,401,506	06-2002	Ogawa et al.	72/14.4
*	D	US-4,116,028	09-1978	Okamoto et al.	72/10.6
*	Ε	US-3,818,742	06-1974	Maltby et al.	72/238
*	F	US-4,154,080	05-1979	Suzuki et al.	72/237
*	G	US-4,089,196	05-1978	Kondo et al.	72/8.6
*	Н	US-3,290,912	12-1966	WARREN REID	72/10.4
*	1	US-3,733,875	05-1973	Steimer, Robert G.	72/237
*	7	US-3,587,266	06-1971	Randich	72/11.8
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 06269818 A	09-1994	Japan	WATANABE et al.	
	0	JP 60046812 A	03-1985	Japan	FURUI et al.	
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

	NON-FAIENT DOCUMENTS				
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	w				
	x				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.